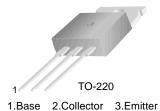


TIP145T/146T/147T

Monolithic Construction With Built In Base-Emitter Shunt Resistors

- High DC Current Gain : $h_{FE} = 1000@V_{CE} = -4V$, $I_{C} = -5A$ (Min.)
- Industrial Use
- Complement to TIP140T/141T/142T

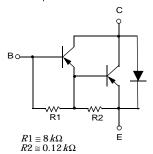


PNP Epitaxial Silicon Darlington Transistor

Absolute Maximum Ratings T_C=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collector-Base Voltage : TIP145T	- 60	V
	: TIP146T	- 80	V
	: TIP147T	- 100	V
	Collector-Emitter Voltage: TIP145T	- 60	V
V_{CEO}	: TIP146T	- 80	V
	: TIP147T	- 100	V
V _{EBO}	Emitter-Base Voltage	- 5	V
I _C	Collector Current (DC)	- 10	Α
I _{CP}	Collector Current (Pulse)	- 15	Α
I _B	Base Current (DC)	- 0.5	Α
P _C	Collector Dissipation (T _C =25°C)	80	W
T_J	Junction Temperature	150	°C
T _{STG}	Storage Temperature	- 65 ~ 150	°C





Electrical Characteristics $T_C=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V _{CEO} (sus)	Collector-Emitter Sustaining Voltage : TIP145T : TIP146T : TIP147T	I _C = - 30mA, I _B = 0	- 60 - 80 - 100			V V
I _{CEO}	Collector Cut-off Current : TIP145T : TIP146T : TIP147T	$V_{CE} = -30V, I_{B} = 0$ $V_{CE} = -40V, I_{B} = 0$ $V_{CE} = -50V, I_{B} = 0$			- 2 - 2 - 2	mA mA mA
I _{CBO}	Collector Cut-off Current : TIP145T : TIP146T : TIP147T	$V_{CB} = -60V, I_{E} = 0$ $V_{CB} = -80V, I_{E} = 0$ $V_{CB} = -100V, I_{E} = 0$			- 1 - 1 - 1	mA mA mA
I _{EBO}	Emitter Cut-off Current	$V_{BE} = -5V, I_{C} = 0$			- 2	mA
h _{FE}	DC Current Gain	V _{CE} = - 4V, I _C = - 5A V _{CE} = - 4V, I _C = - 10A	1000 500			
V _{CE} (sat)	Collector-Emitter Saturation Voltage	I _C = - 5A, I _B = - 10mA I _C = - 10A, I _B = - 40mA			- 2 - 3	V V
V _{BE} (sat)	Base-Emitter Saturation Voltage	$I_C = -10A, I_B = -40mA$			- 3.5	V
V _{BE} (on)	Base-Emitter On Voltage	V _{CE} = - 4V, I _C = - 10A			- 3	V
t _D	Delay Time	$V_{CC} = -30V, I_{C} = -5A$		0.15		μs
t _R	Rise Time	$I_{B1} = -20 \text{mA}, I_{B2} = 20 \text{mA}$		0.55		μs
t _{STG}	Storage Time	$R_L = 6\Omega$		2.5		μs
t _F	Fall Time			2.5		μs

Typical Characteristics

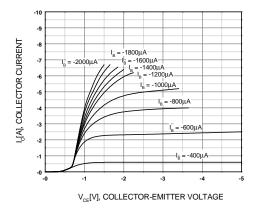


Figure 1. Static Characteristic

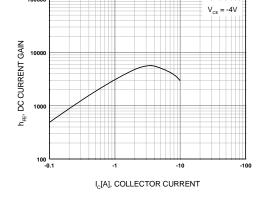


Figure 2. DC current Gain

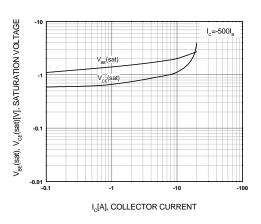


Figure 3. Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage

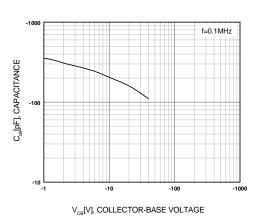


Figure 4. Collector Output Capacitance

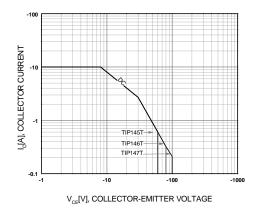


Figure 5. Safe Operating Area

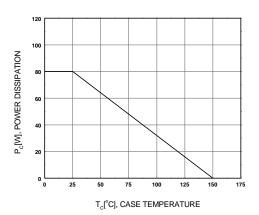


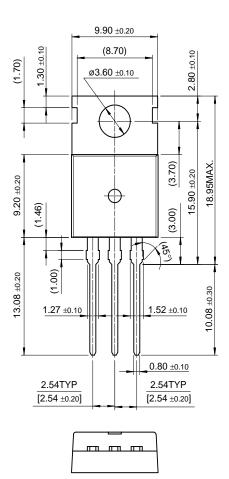
Figure 6. Power Derating

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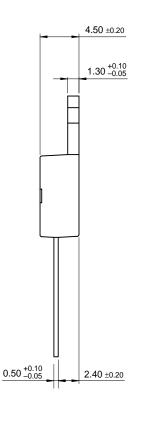
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Package Dimensions

TO-220



 10.00 ± 0.20



Dimensions in Millimeters

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